

**Notice of References Cited**

Application/Control No.

09/712,580

Applicant(s)/Patent Under

Examination  
ESQUIBEL ET AL.

Examiner

Chriss S. Yoder, III

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,005,613 A	12-1999	Endsley et al.	348/231.6
	B	US-6,665,015 B1	12-2003	Watanabe et al.	348/362
	C	US-5,479,206 A	12-1995	Ueno et al.	348/211.5
	D	US-5,648,814 A	07-1997	Munson, Bill	348/14.1
	E	US-4,584,610	04-1986	Mizokami et al.	348/229.1
	F	US-6,715,003 B1	03-2004	Safai, Mohammad A.	710/33
	G	US-5,926,219 A	07-1999	Shimizu et al.	348/362
	H	US-4,954,897	09-1990	Ejima et al.	348/229.1
	I	US-5,159,364 A	10-1992	Yanagisawa et al.	396/76
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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